40 1 W S

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Sylvia H. Pas

Examiner: TBD

Serial No:

TBD

Art Unit:

TBD

Filed:

01/11/01

Docket No.: TI-22398

For:

SYSTEM AND METHOD FOR INTEGRATED OXIDE REMOVAL AND

PROCESSING OF A SEMICONDUCTOR WAFER

PRELIMINARY AMENDMENT

January 11, 2001

Assistant Commissioner for Patents

Washington, DC 20231

Dear Sir:

Please amend the above referenced application as follows:

In the Specification:

Page 1, before line 1, insert -- This application claims priority under 35 USC § 119(e)(1) of provisional application numbers 60/178,647 filed 01/28/00.--

REMARKS

Entry of the foregoing amendment prior to examination is respectfully requested.

If the Examiner has any questions or other correspondence regarding this application, Applicant requests that the Examiner contact Applicant's attorney at the below listed telephone number and address.

Respectfully submitted,

Texas Instruments Incorporated P. O. Box 655474, MS 3999 Dallas, Texas 75265 (972) 271-1176

Fax: (972) 917-4417 or (972) 917-4418

Jacqueline J. Garner Attorney for Applicants Reg. No. 36,144